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An apparatus for removing semiconductor wafers from within the runner disks in a double-sided polishing machine, comprising:

a suction head (52) adapted to be connected to a vacuum, which has a plurality of suction ports (60, 61) such that all semiconductor wafers (26) received by a runner disk (24) may be gripped simultaneously;

an arm (50) on which the suction head (52) is rotatably supported about a vertical axis and which, in turn, is pivotally supported about a vertical axis at a spacing from the suction head or is supported so as to be linearly adjustable or adjustable in height;

a rotary drive (52') for the suction head (52), a drive (30) for the arm (52), a lifting drive for the arm (52), and

a control device for activating the drives such that the semiconductor wafers (26) may be deposited on a lay-down device (74) in a predetermined, aligned position.

- 2. The apparatus according to claim 1, characterized in that the runner disks (24) have a mark (64), the suction head (52) has a sensor (70) for detecting the mark (64) and the control device, while rotating the suction head (52), moves it to a predetermined rotational position relative to the runner disk (24).
- rel The apparatus according to claim 1, characterized in that the mark (64) is a deepened point, especially a bore.
 - 4. The apparatus according to claim 1, characterized in that the suction head (52) has two suction cups (60, 61) for each semiconductor wafer (26) which lie on a radius of the semiconductor wafer (26) when the suction head (52) is aligned towards a runner disk (24).
 - 5. The apparatus according to claim 4, characterized in that one suction cup (61) is aligned towards the centre of the respective semiconductor wafer (26).



- 6. The apparatus according to claim 1, characterized in that the lay-down device (72) has a circular plate (74) adapted to be driven by a rotary drive which is subdivided into three sectors (76, 76a) wherein each sector (76, 76a) has at least one nest (78, 78a) to receive a semiconductor wafer and is supported so as to be tiltable about a horizontal axis and one sector (76, 76a) each is adapted to be aligned towards a transfer portion (82, 98) leading to a cassette.
- 7. The apparatus according to claim 1, characterized in that immersion baths (80) for the suction cups (60, 61) of the suction head (52) are arranged in the nests (78, 78a).
- 10 8. The apparatus according to claim 1, characterized in that the arm (50) is mounted on a carriage (46) which is held on a carrier element (38) having a linear guide (44) so as to be guided vertically and that the carrier element (38) is rotatably supported on the machine frame (10, 28).
- The first term of the first te The apparatus according to claim 1, characterized in that the arm (50) is pivotally supported about a vertical axis on a bearing component (28a) and is driven by a swivel drive and that the bearing component (28a) is movably supported along a linear guide (100) which is arranged between the polishing machine and a second polishing machine and that the bearing component (28a) is adapted to be displaced by an actuator drive along the guide (100).
 - The apparatus according to claim 9, characterized in that the upper polishing disks of the 10. two polishing machines are pivotally supported about a vertical axis towards opposed sides.



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